

4N25

4N26

4N27

4N28

NPN PHOTOTRANSISTOR AND PN INFRARED EMITTING DIODE

... Gallium Arsenide LED optically coupled to a Silicon Photo Transistor designed for applications requiring electrical isolation, high-current transfer ratios, small package size and low cost; such as interfacing and coupling systems, phase and feedback controls, solid-state relays and general-purpose switching circuits.

- High Isolation Voltage —
V_{ISO} = 2500 V (Min) — 4N25
1500 V (Min) — 4N26, 4N27
500 V (Min) — 4N28
- Excellent Frequency Response —
300 kHz (Typ)
- High Collector Output Current
@ I_F = 10 mA —
I_C = 5.0 mA (Typ) — 4N25, 4N26
3.0 mA (Typ) — 4N27, 4N28
- Fast Switching Times @ I_C = 10 mA
t_{on} = 0.87 μs (Typ) — 4N25, 4N26
2.1 μs (Typ) — 4N27, 4N28
t_{off} = 11 μs (Typ) — 4N25, 4N26
5.0 μs (Typ) — 4N27, 4N28
- Economical, Compact, Dual-In-Line Package

*MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
INFRARED EMITTING DIODE MAXIMUM RATINGS			
Reverse Voltage	V _R	3.0	Volts
Forward Current — Continuous	I _F	80	mA
Forward Current — Peak Pulse Width = 300 μs, 2.0% Duty Cycle	I _F	3.0	Amps
Total Device Dissipation @ T _A = 25°C Negligible Power in Transistor Derate above 25°C	P _D	150	mW
		2.0	mW/°C

PHOTOTRANSISTOR MAXIMUM RATINGS			
Collector-Emitter Voltage	V _{CEO}	30	Volts
Emitter-Collector Voltage	V _{ECO}	7.0	Volts
Collector-Base Voltage	V _{CBO}	70	Volts
Total Device Dissipation @ T _A = 25°C Negligible Power in Diode Derate above 25°C	P _D	150	mW
		2.0	mW/°C

TOTAL DEVICE RATINGS			
Total Device Dissipation @ T _A = 25°C Equal Power Dissipation in Each Element Derate above 25°C	P _D	250	mW
		3.3	mW/°C
Junction Temperature Range	T _J	-55 to +100	°C
Storage Temperature Range	T _{stg}	-55 to +150	°C
Soldering Temperature (10 s)		260	°C

* Indicates JEDEC Registered Data.

FIGURE 1 — MAXIMUM POWER DISSIPATION

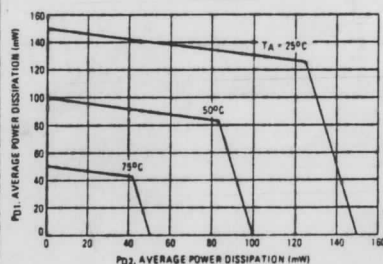
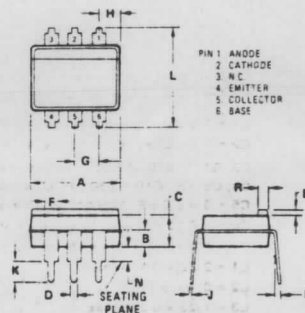
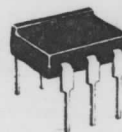


Figure 1 is based upon using limit values in the equation:
 $T_{J1} - T_A = R_{\theta JA} (P_{D1} + K_{\theta} P_{D2})$
 where:
 T_{J1} Junction Temperature (100°C)
 T_A Ambient Temperature
 $R_{\theta JA}$ Junction to Ambient Thermal Resistance (500°C/W)
 P_{D1} Power Dissipation in One Chip
 P_{D2} Power Dissipation in Other Chip
 K_{θ} Thermal Coupling Coefficient (20%)

Example:
 With $P_{D1} = 90$ mW in the LED
 @ $T_A = 50^\circ\text{C}$, the transistor
 P_D (P_{D2}) must be less than 50 mW.

INFRARED LIGHT EMITTING DIODE PHOTOTRANSISTOR COUPLED PAIR



DIM	MIN	MAX	MIN	MAX
A	8.38	8.89	0.330	0.350
B	1.40	1.65	0.055	0.065
C	2.92	3.18	0.115	0.125
D	0.41	0.51	0.016	0.020
E	0.64	0.89	0.025	0.035
F	1.14	1.40	0.045	0.055
G	2.54 BSC		0.100 BSC	
H	1.57	1.83	0.062	0.072
J	0.23	0.28	0.009	0.011
K	2.54	3.30	0.100	0.130
L	7.37	7.87	0.290	0.310
M	—	50	—	50
N	—	1.27	—	0.050
R	1.52	1.78	0.060	0.070

CASE 673-03

LED CHARACTERISTICS ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
*Reverse Leakage Current ($V_R = 3.0\text{ V}$, $R_L = 1.0\text{ M ohm}$)	I_R	—	0.05	100	μA
*Forward Voltage ($I_F = 50\text{ mA}$)	V_F	—	1.2	1.5	Volts
Capacitance ($V_R = 0\text{ V}$, $f = 1.0\text{ MHz}$)	C	—	150	—	pF

PHOTOTRANSISTOR CHARACTERISTICS ($T_A = 25^\circ\text{C}$ and $I_F = 0$ unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
*Collector-Emitter Dark Current ($V_{CE} = 10\text{ V}$, Base Open)	I_{CEO}	—	3.5	50	nA
*Collector-Base Dark Current ($V_{CB} = 10\text{ V}$, Emitter Open)	I_{CBO}	—	—	20	nA
*Collector-Base Breakdown Voltage ($I_C = 100\text{ }\mu\text{A}$, $I_E = 0$)	BV_{CBO}	70	—	—	Volts
*Collector-Emitter Breakdown Voltage ($I_C = 1.0\text{ mA}$, $I_E = 0$)	BV_{CEO}	30	—	—	Volts
*Emitter-Collector Breakdown Voltage ($I_E = 100\text{ }\mu\text{A}$, $I_B = 0$)	BV_{ECO}	7.0	—	—	Volts
DC Current Gain ($V_{CE} = 5.0\text{ V}$, $I_C = 500\text{ }\mu\text{A}$)	h_{FE}	—	250	—	—

COUPLED CHARACTERISTICS ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
*Collector Output Current (1) ($V_{CE} = 10\text{ V}$, $I_F = 10\text{ mA}$, $I_B = 0$)	I_C	2.0 1.0	5.0 3.0	—	mA
*Isolation Voltage (2)	V_{ISO}	2500 1500 500	—	—	Volts
Isolation Resistance (2) ($V = 500\text{ V}$)			10^{11}	—	Ohms
*Collector-Emitter Saturation ($I_C = 2.0\text{ mA}$, $I_F = 50\text{ mA}$)	$V_{CE(sat)}$		0.2	0.5	Volts
Isolation Capacitance (2) ($V = 0$, $f = 1.0\text{ MHz}$)			1.3	—	pF
Bandwidth (3) ($I_C = 2.0\text{ mA}$, $R_L = 100\text{ ohms}$, Figure 11)			300	—	kHz

SWITCHING CHARACTERISTICS

Delay Time ($I_C = 10\text{ mA}$, $V_{CC} = 10\text{ V}$)	4N25, 4N26 4N27, 4N28	t_d	—	0.07 0.10	—	μs
Rise Time Figures 6 and 8	4N25, 4N26 4N27, 4N28	t_r	—	0.8 2.0	—	μs
Storage Time ($I_C = 10\text{ mA}$, $V_{CC} = 10\text{ V}$)	4N25, 4N26 4N27, 4N28	t_s	—	4.0 2.0	—	μs
Fall Time Figures 7 and 8	4N25, 4N26 4N27, 4N28	t_f	—	7.0 3.0	—	μs

* Indicates JEDEC Registered Data. (1) Pulse Test. Pulse Width: 300 μs . Duty Cycle: 20%.

(2) For this test LED pins 1 and 2 are common and Photo Transistor pins 4, 5 and 6 are common.

(3) I_F adjusted to yield $I_C = 2.0\text{ mA}$ and $t_c = 2.0\text{ mA p.p}$ at 10 kHz.

DC CURRENT TRANSFER CHARACTERISTICS

FIGURE 2 — 4N25, 4N26

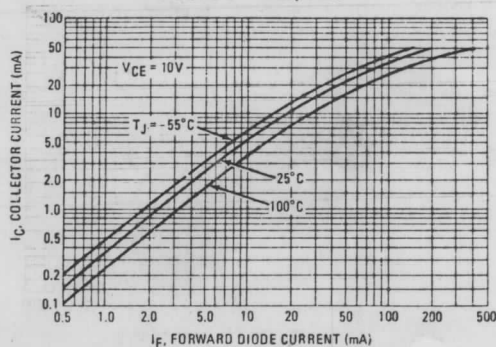
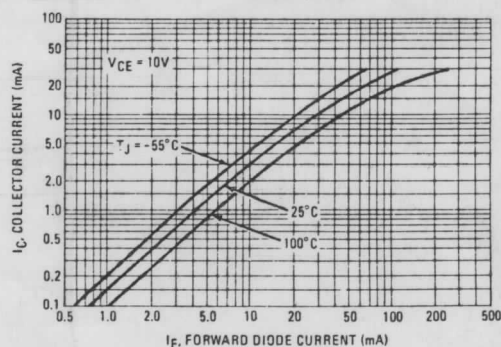


FIGURE 3 — 4N27, 4N28



TYPICAL ELECTRICAL CHARACTERISTICS

FIGURE 4 - DIODE FORWARD CHARACTERISTICS

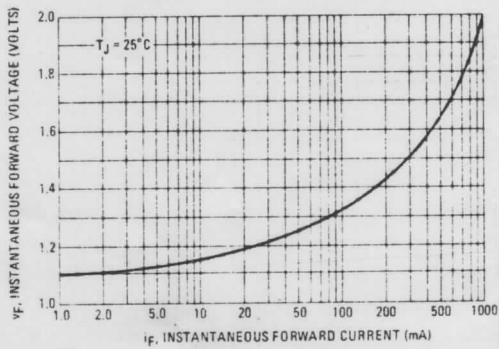


FIGURE 5 - COLLECTOR SATURATION VOLTAGE

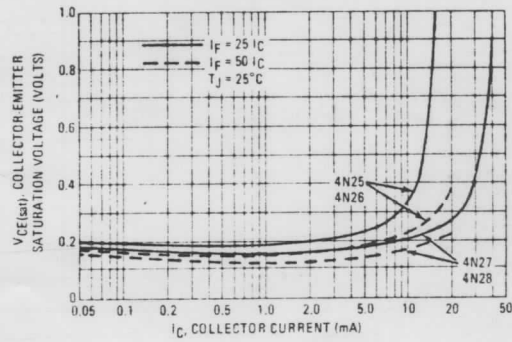


FIGURE 6 - TURN-ON TIME

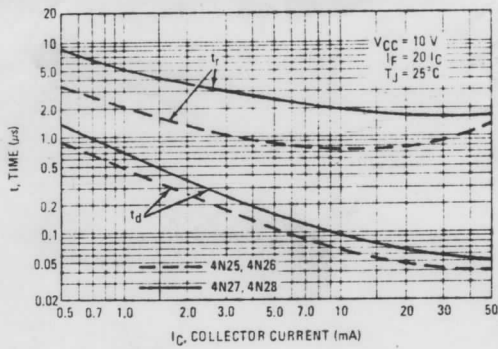


FIGURE 7 - TURN-OFF TIME

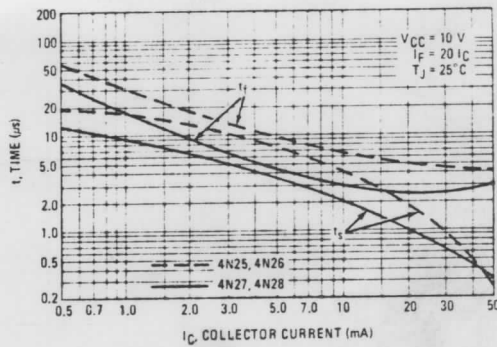


FIGURE 8 - SATURATED SWITCHING TIME TEST CIRCUIT

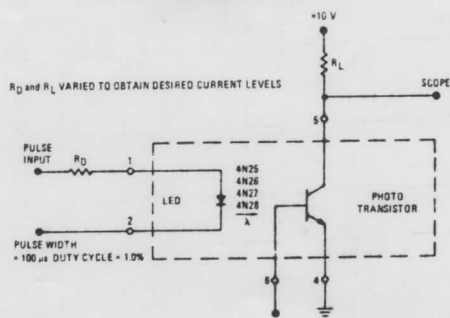


FIGURE 9 - DARK CURRENT versus AMBIENT TEMPERATURE

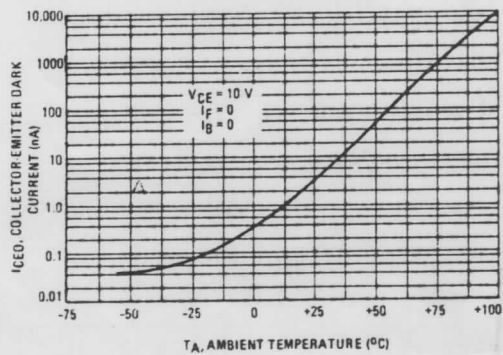


FIGURE 10 - FREQUENCY RESPONSE

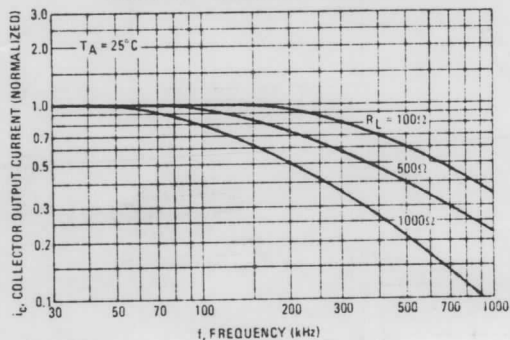
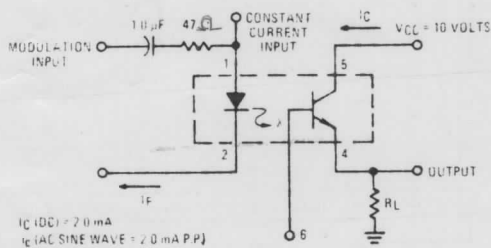


FIGURE 11 - FREQUENCY RESPONSE TEST CIRCUIT



TYPICAL APPLICATIONS

FIGURE 12 - ISOLATED M TTL TO MOS (P-CHANNEL) LEVEL TRANSLATOR

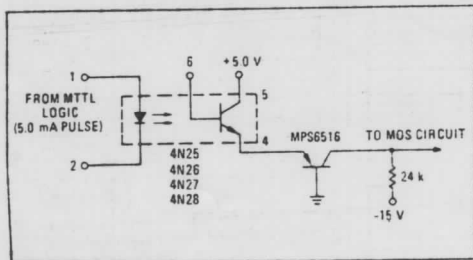


FIGURE 13 - COMPUTER/PERIPHERAL INTERCONNECT

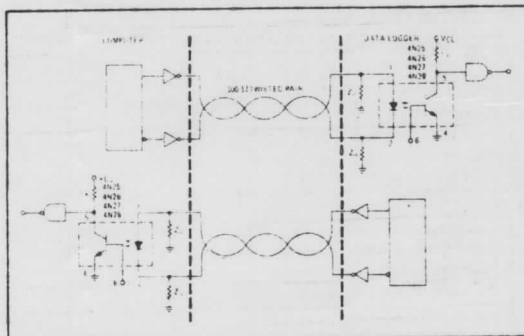


FIGURE 14 - POWER AMPLIFIER

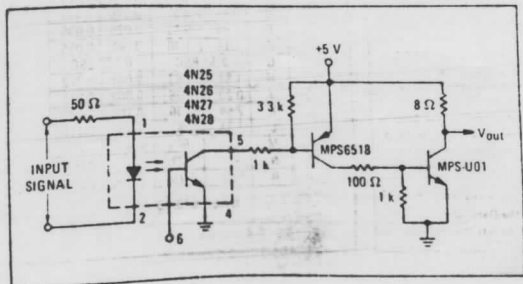
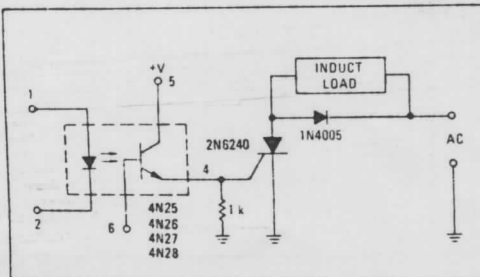


FIGURE 15 - INTERFACE BETWEEN LOGIC AND LOAD



Typical Electrical Characteristics

4N35
4N36
4N37

Electrical Characteristics—Input Diode $T_A = 25^\circ\text{C}$

Symbol	Characteristic	Min	Typ	Max	Units	Test Conditions
V_F^*	Forward Voltage	0.8		1.5	V	$I_F = 10\text{ mA}$
I_R^*	Reverse Leakage Current		0.01	10	μA	$V_R = 6.0\text{ V}$
C	Capacitance			100	pF	$V_R = 0\text{ V}$ $f = 1\text{ MHz}$

Electrical Characteristics—Output Transistor $T_A = 25^\circ\text{C}$

Symbol	Characteristic	Min	Typ	Max	Units	Test Conditions
V_{CE0}^*	Collector-to-Emitter Voltage	30	65		V	$I_C = 10\text{ mA}$
V_{CB0}^*	Collector-to-Base Voltage	70	165		V	$I_C = 100\text{ }\mu\text{A}$
V_{ECO}^*	Emitter-to-Collector Voltage	7.0	14		V	$I_E = 100\text{ }\mu\text{A}$ $I_F = 0$
I_{CE0}^*	Collector-to-Emitter Leakage Current		5.0	50	nA	$V_{CE} = 10\text{ V}$ $I_F = 0$
I_{CEO}^*	Collector-to-Emitter Leakage Current			500	μA	$V_{CE} = 30\text{ V}$ $I_F = 0$ $T_A = 100^\circ\text{C}$
h_{FE}	Forward Current Gain	100	250			$V_{CE} = 5.0\text{ V}$ $I_C = 100\text{ }\mu\text{A}$
C_{cb}	Collector-to-Base Capacitance		25		pF	$V_{CB} = 10\text{ V}$

Electrical Characteristics—Coupled $T_A = 25^\circ\text{C}$

Symbol	Characteristic	Min	Typ	Max	Units	Test Conditions
I_{IO}^*	Input-to-Output Current			100	μA	$PW = 8\text{ ms}$ $V_{IO} = 3550\text{ V}$
	4N35			100	μA	$V_{IO} = 2500\text{ V}$
	4N36			100	μA	$V_{IO} = 1500\text{ V}$
	4N37			0.3	V	$I_C = 0.5\text{ mA}$ $I_F = 10\text{ mA}$
$V_{CE(sat)}^*$	Collector-to-Emitter Saturation Voltage					$V_{CE} = 10\text{ V}$ $I_F = 10\text{ mA}$
$I_C/I_F(\text{CTR})^*$	Collector Current Transfer Ratio (Note)	100			%	$V_{CE} = 10\text{ V}$ $I_F = 10\text{ mA}$
$I_C/I_F(\text{CTR})^*$	Collector Current Transfer Ratio (Note)	40			%	$V_{CE} = 10\text{ V}$ $I_F = 10\text{ mA}$ $T_A = -55^\circ\text{C}$ to 100°C
R_{IO}	Input-to-Output Resistance	10^{11}	1.0	2.5	Ω	$V_{IO} = 500\text{ V}$
C_{IO}	Input-to-Output Capacitance				pF	$V_{IO} = 0$ $f = 1.0\text{ MHz}$
t_{on}	Turn-on Time		5.0	10	μs	$I_C = 2.0\text{ mA}$ $V_{CC} = 10\text{ V}$ $R_L = 100\text{ }\Omega$
t_{off}	Turn-off Time		5.0	10	μs	$I_C = 2.0\text{ mA}$ $V_{CC} = 10\text{ V}$ $R_L = 100\text{ }\Omega$

Notes

Collector current transfer ratio is defined as the ratio of the collector current to the forward bias input current.

*Indicates JEDEC registered values.

LSTTL/TTL Optocoupler

Optoelectronic Product

General Description

The 6N137 optocoupler consists of an infrared emitting diode and a photodiode. The photodiode is connected in a common-emitter configuration and is amplified by a high-gain Schottky-clamped emitter-follower. The output is a logic-level signal, current, or voltage, depending on the circuit.

This isolator design provides excellent isolation between the input and output. It is capable of sinking or sourcing up to 10 mA at 5 V and is suitable for operation from -55°C to 100°C . The output is a logic-level signal, current, or voltage, depending on the circuit.

The 6N137 is available in a variety of packages and is suitable for use in a wide range of applications. It is particularly well suited for use in digital systems where high-speed, high-voltage isolation is required.

LSTTL/TTL Core
Ultra High Speed
Low Input Current
High Common-Mode Rejection
Guaranteed Performance
3000 V dc Insulation

Absolute Maximum Ratings
Up to 70°C

Maximum Temperature
Operating Temperature
Storage Temperature
Pin Temperature
(1.6 mm below surface)

Maximum Power
Output Collector Current
Dissipation

*JEDEC Registered Values

Optically-Coupled Isolator

Optoelectronic Products

4N35
4N36
4N37

General Description

The 4N35, 4N36 and 4N37 series of optoisolators has a silicon npn Planar phototransistor in close proximity to a GaAs diode. Optical coupling provides a high degree of ac and dc isolation. A capability for continuous operation of the input diode results in a frequency response extending to dc. Connection to the transistor base is also provided for design flexibility. This isolator series is covered under UL component recognition program, reference file E55299.

Glassolated™

High Current Transfer Ratio—Minimum 100%
1500 V to 3500 V Minimum Isolation

Input-to-Output

10¹¹ Ω Isolation Resistance

Low Coupling Capacitance—Typically 1.0 pF

Absolute Maximum Ratings

Maximum Temperature and Humidity

Storage Temperature*	-55°C to +150°C
Operating Temperature	-55°C to +100°C
Pin Temperature (Soldering, 10s)*	260°C
Relative Humidity at 85°C*	85%

Input Diode

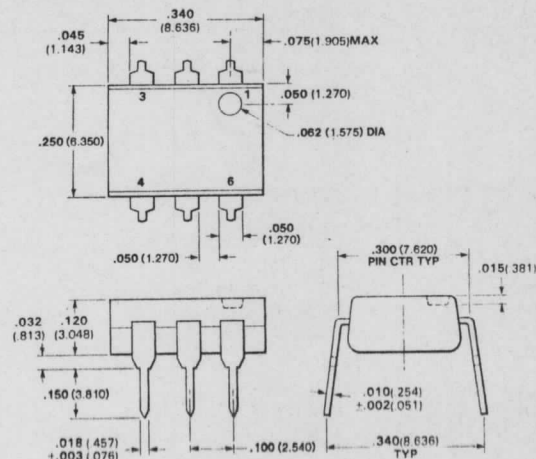
V _R *	Reverse Voltage	6.0 V
I _F *	Forward Current	60 mA
I _{pk} *	Peak Forward Current at 1 μs pulse width, 300 pps	3.0 A
P _D *	Power Dissipation at T _A = 25°C	100 mW
	Derate Linearly from 25°C	1.33 mW/°C

Output Transistor

V _{CE} *	Collector-to-Emitter Voltage	30 V
V _{CB} *	Collector-to-Base Voltage	70 V
V _{EC} *	Emitter-to-Collector Voltage	7.0 V
I _C *	Collector Current	100 mA
P _D *	Power Dissipation at T _A = 25°C	300 mW
	Derate Linearly from 25°C	4.0 mW/°C

*Indicates JEDEC registered values.

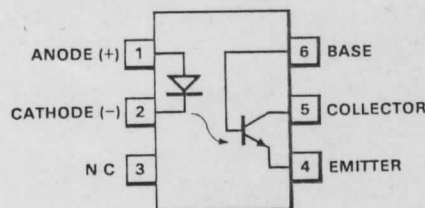
Package Outline



Notes

All dimension in inches bold and millimeters (parentheses)
Tolerance unless specified = ±0.15 (0.381)

Connection Diagram DIP (Top View)



Pin

1	Anode (+)	} Input Diode
2	Cathode (-)	
3	NC	
4	Emitter	} Output npn Phototransistor
5	Collector	
6	Base	

TYPES TIL111, TIL114, TIL116, TIL117 OPTO-COUPLEDERS

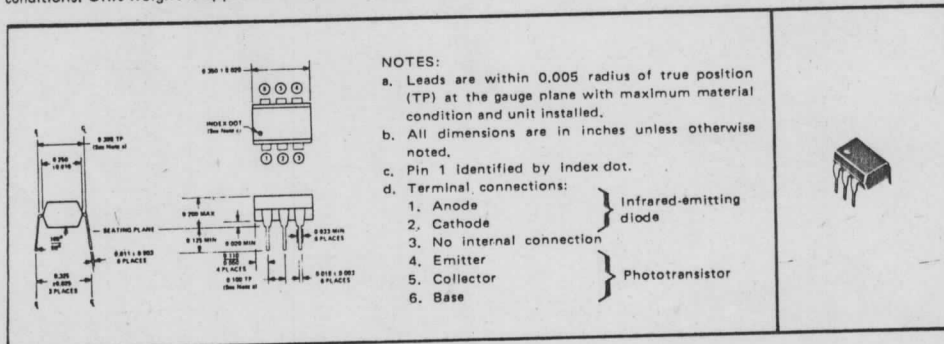
BULLETIN NO. DL-S 7312030, NOVEMBER 1973

COMPATABLE WITH STANDARD DTL AND TTL INTEGRATED CIRCUITS

- Gallium Arsenide Diode Infrared Source Optically Coupled to a Silicon N-P-N Phototransistor
- High Direct-Current Transfer Ratio
- Base Lead Provided for Conventional Transistor Biasing
- High-Voltage Electrical Isolation . . . 1.5-kV or 2.5-kV Rating
- Plastic Dual-In-Line Package
- High-Speed Switching: $t_r = 2 \mu s$, $t_f = 2 \mu s$ Typical

mechanical data

The package consists of a gallium arsenide infrared-emitting diode and an n-p-n silicon phototransistor mounted on a 6-lead frame encapsulated within an electrically nonconductive plastic compound. The case will withstand soldering temperature with no deformation and device performance characteristics remain stable when operated in high-humidity conditions. Unit weight is approximately 0.52 grams.



absolute maximum ratings at 25°C free-air temperature (unless otherwise noted)

Input-to-Output Voltage: TIL111	±1.5 kV
TIL114, TIL116, TIL117	±2.5 kV
Collector-Base Voltage	70 V
Collector-Emitter Voltage (See Note 1)	30 V
Emitter-Collector Voltage	7 V
Emitter-Base Voltage	7 V
Input-Diode Reverse Voltage	3 V
Input-Diode Continuous Forward Current at (or below) 25°C Free-Air Temperature (See Note 2)	100 mA
Continuous Power Dissipation at (or below) 25°C Free-Air Temperature:	
Infrared-Emitting Diode (See Note 3)	150 mW
Phototransistor (See Note 4)	150 mW
Total, Infrared-Emitting Diode plus Phototransistor (See Note 5)	250 mW
Storage Temperature Range	-55°C to 150°C
Lead Temperature 1/16 Inch from Case for 10 Seconds	260°C

- NOTES:
- This value applies when the base-emitter diode is open-circuited.
 - Derate linearly to 100°C free-air temperature at the rate of 1.33 mW/°C.
 - Derate linearly to 100°C free-air temperature at the rate of 2 mW/°C.
 - Derate linearly to 100°C free-air temperature at the rate of 2 mW/°C.
 - Derate linearly to 100°C free-air temperature at the rate of 3.33 mW/°C.

TEXAS INSTRUMENTS
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TYPES TIL111, TIL114, TIL116, TIL117 OPTO-COUPLEDERS

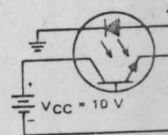
electrical characteristics at 25°C free-air temperature

PARAMETER		TEST CONDITIONS	TIL111 TIL114			TIL116			TIL117			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
$V_{(BR)CBO}$	Collector-Base Breakdown Voltage	$I_C = 10 \mu A, I_E = 0, I_F = 0$	70			70			70			V
$V_{(BR)CEO}$	Collector-Emitter Breakdown Voltage	$I_C = 1 mA, I_B = 0, I_F = 0$	30			30			30			V
$V_{(BR)EBO}$	Emitter-Base Breakdown Voltage	$I_E = 10 \mu A, I_C = 0, I_F = 0$	7			7			7			V
I_R	Input Diode Static Reverse Current	$V_R = 3 V$		10			10			10		μA
$I_{C(on)}$	On-State Collector Current	Phototransistor Operation $V_{CE} = 0.4 V, I_F = 16 mA, I_B = 0$	2	7								mA
		$V_{CE} = 10 V, I_F = 10 mA, I_B = 0$				2	5		5	9		
$I_{C(off)}$	Off-State Collector Current	Photodiode Operation $V_{CB} = 0.4 V, I_F = 16 mA, I_E = 0$	10	20		10	20		10	20		μA
		Phototransistor Operation $V_{CE} = 10 V, I_F = 0, I_B = 0$		1	50		1	50		1	50	
h_{FE}	Transistor Static Forward Current Transfer Ratio	$V_{CE} = 5 V, I_C = 10 mA, I_F = 0$	100	300					200	550		
		$V_{CE} = 5 V, I_C = 100 \mu A, I_F = 0$				100	300					
V_F	Input Diode Static Forward Voltage	$I_F = 16 mA$	1.2	1.4					1.2	1.4		V
		$I_F = 60 mA$				1.25	1.5					
$V_{CE(sat)}$	Collector-Emitter Saturation Voltage	$I_C = 2 mA, I_F = 16 mA, I_B = 0$	0.25	0.4								V
		$I_C = 2.2 mA, I_F = 15 mA, I_B = 0$				0.25	0.4					
		$I_C = 0.5 mA, I_F = 10 mA, I_B = 0$							0.25	0.4		
r_{IO}	Input-to-Output Internal Resistance	$V_{in-out} = \pm 1.5 kV$ for TIL111, $\pm 2.5 kV$ for all others, See Note 6	10^{11}			10^{11}			10^{11}			Ω
C_{IO}	Input-to-Output Capacitance	$V_{in-out} = 0, f = 1 MHz$, See Note 6	1	1.3		1	1.3		1	1.3		pF

NOTE 6: These parameters are measured between both input-diode leads shorted together and all the phototransistor leads shorted together.

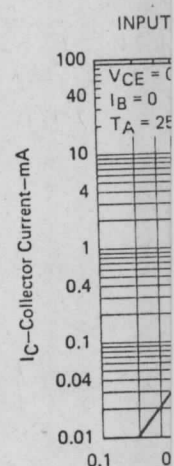
switching characteristics at 25°C free-air temperature

PARAMETER		TEST CONDITIONS	TIL111 TIL114			TIL116			TIL117			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
t_r	Rise Time	Phototransistor Operation $V_{CC} = 10 V, I_{C(on)} = 2 mA, R_L = 100 \Omega$, See Test Circuit A of Figure 1	2	5		2	7		2	9		μs
t_f	Fall Time		2	5		2	7		2	9		
t_r	Rise Time	Photodiode Operation $V_{CC} = 10 V, I_{C(on)} = 20 \mu A, R_L = 1 k\Omega$, See Test Circuit B of Figure 1	1			1			1			μs
t_f	Fall Time		1			1			1			



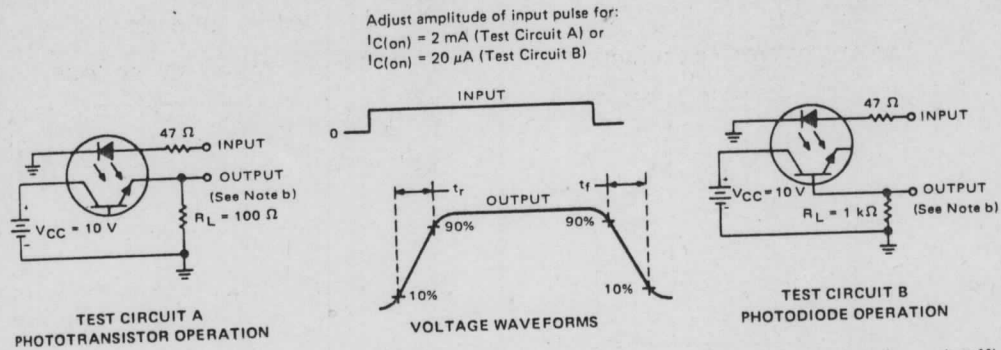
TEST CIRCUIT
PHOTOTRANSISTOR

NOTES: a. The input $t_w = 100 \mu s$
b. The output



TYPES TIL111, TIL114, TIL116, TIL117 OPTO-COUPLEDERS

PARAMETER MEASUREMENT INFORMATION



NOTES: a. The input waveform is supplied by a generator with the following characteristics: $Z_{out} = 50 \Omega$, $t_r \leq 15 \text{ ns}$, duty cycle $\approx 1\%$, $t_w = 100 \mu\text{s}$.
 b. The output waveform is monitored on an oscilloscope with the following characteristics: $t_r \leq 12 \text{ ns}$, $R_{in} \geq 1 \text{ M}\Omega$, $C_{in} \leq 20 \text{ pF}$.

FIGURE 1—SWITCHING TIMES

TYPICAL CHARACTERISTICS

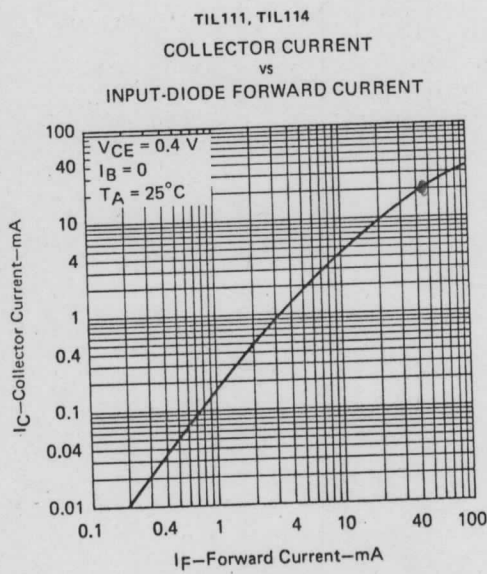


FIGURE 2

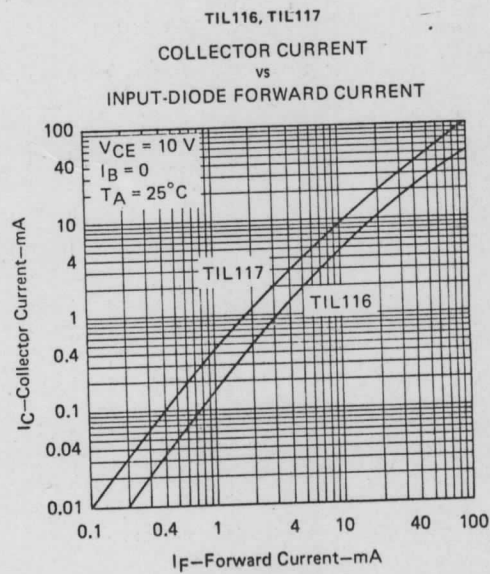
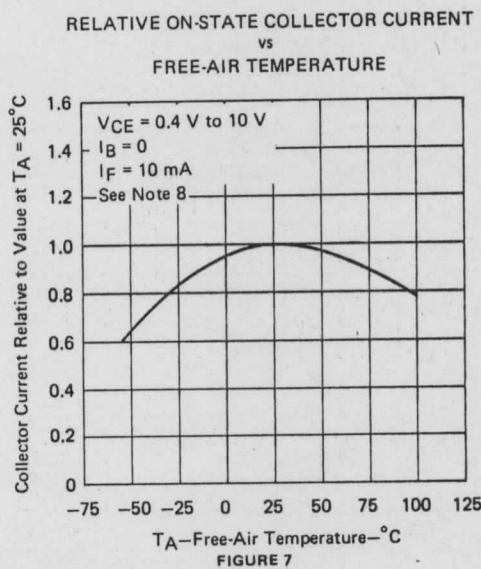
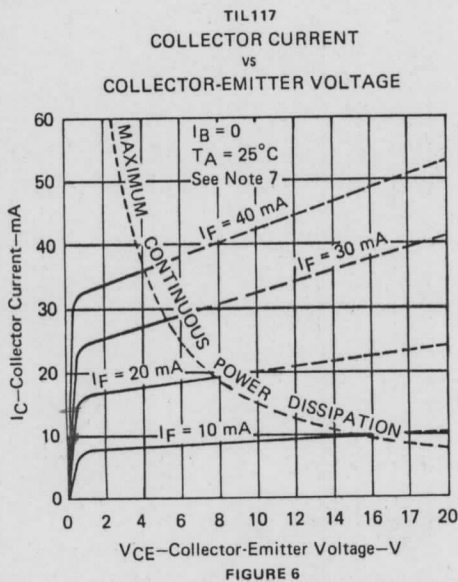
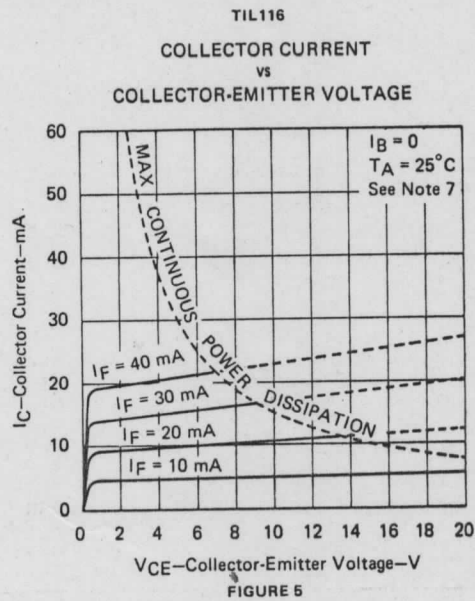
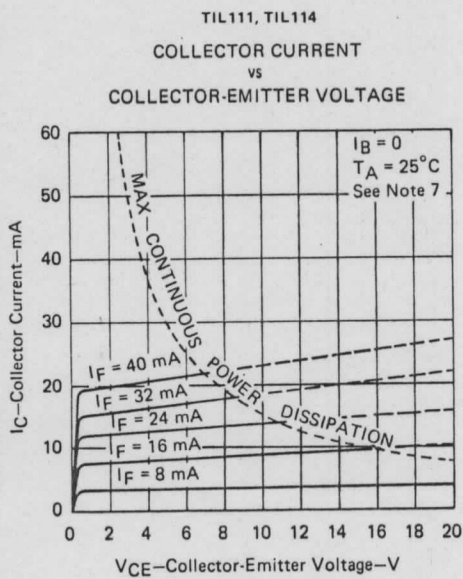


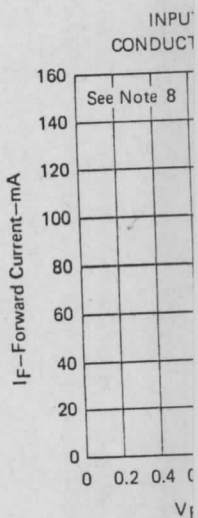
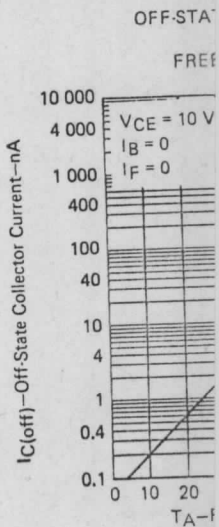
FIGURE 3

TYPES TIL111, TIL114, TIL116, TIL117 OPTO-COUPLEDERS

TYPICAL CHARACTERISTICS



NOTES: 7. Pulse operation of input diode is required for operation beyond limits shown by dotted lines.
8. These parameters were measured using pulse techniques. $t_W = 1$ ms, duty cycle $< 2\%$.



NOTE 8: These parameters were measured using pulse techniques. $t_W = 1$ ms, duty cycle $< 2\%$.

TYPES TIL111, TIL114, TIL116, TIL117 OPTO-COUPLEDERS

TYPICAL CHARACTERISTICS

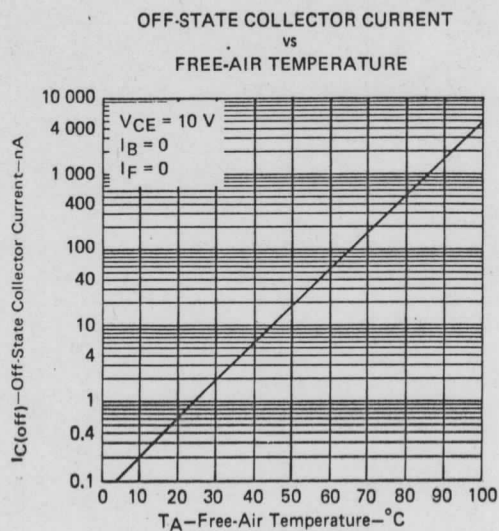


FIGURE 8

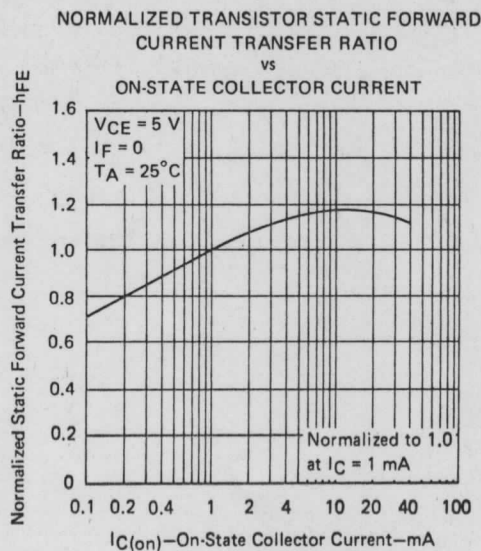


FIGURE 9

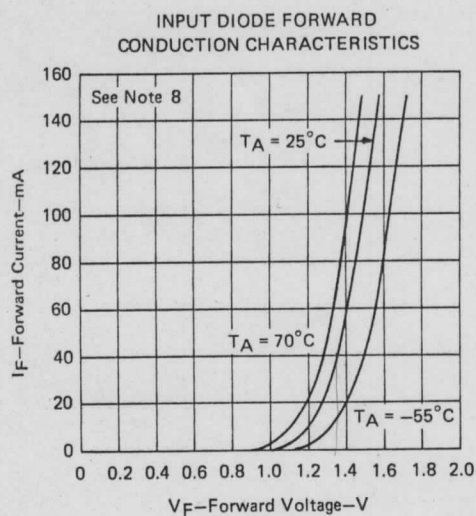


FIGURE 10

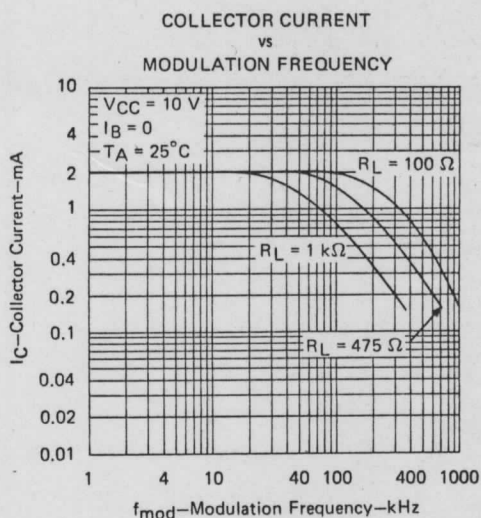


FIGURE 11

NOTE 8: These parameters were measured using pulse techniques. $t_w = 1\text{ ms}$, duty cycle $\leq 2\%$.

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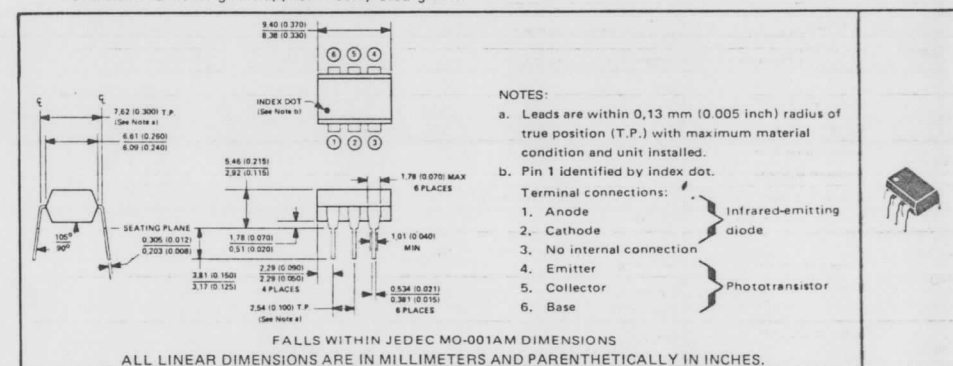
TEXAS INSTRUMENTS
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POST OFFICE BOX 5012 • DALLAS, TEXAS 75222

- Gallium Arsenide Diode Infrared Source Optically Coupled to a Silicon N-P-N Phototransistor
- High Direct-Current Transfer Ratio
- Base Lead Provided for Conventional Transistor Biasing (TIL112, TIL115)
- High-Voltage Electrical Isolation . . . 1.5-kV or 2.5-kV Rating
- Plastic Dual-In-Line Package
- High-Speed Switching: $t_r = 2 \mu s$, $t_f = 2 \mu s$ Typical

mechanical data

The package consists of a gallium arsenide infrared-emitting diode and an n-p-n silicon phototransistor mounted on a 6-lead frame encapsulated within an electrically nonconductive plastic compound. The case will withstand soldering temperature with no deformation and device performance characteristics remain stable when operated in high-humidity conditions. Unit weight is approximately 0.52 grams.



absolute maximum ratings at 25°C free-air temperature (unless otherwise noted)

	TIL112	TIL115	TIL118
Input-to-Output Voltage	±1.5 kV	±2.5 kV	±1.5 kV
Collector-Base Voltage	30 V	30 V	30 V
Collector-Emitter Voltage (See Note 1)	20 V	20 V	20 V
Emitter-Collector Voltage	4 V	4 V	4 V
Emitter-Base Voltage	4 V	4 V	
Input-Diode Reverse Voltage	3 V	3 V	3 V
Input-Diode Continuous Forward Current at (or below)			
25°C Free-Air Temperature (See Note 2)	100 mA		
Continuous Power Dissipation at (or below) 25°C Free-Air Temperature:			
Infrared-Emitting Diode (See Note 3)	150 mW		
Phototransistor (See Note 4)	150 mW		
Total (Infrared-Emitting Diode plus Phototransistor, See Note 5)	250 mW		
Storage Temperature Range	-55°C to 150°C		
Lead Temperature 1.6 mm (1/16 Inch) from Case for 10 Seconds	260°C		

- NOTES:
- This value applies when the base-emitter diode is open-circuited.
 - Derate linearly to 100°C free-air temperature at the rate of 1.33 mW/°C.
 - Derate linearly to 100°C free-air temperature at the rate of 2 mW/°C.
 - Derate linearly to 100°C free-air temperature at the rate of 2 mW/°C.
 - Derate linearly to 100°C free-air temperature at the rate of 3.33 mW/°C.

TYPES TIL112, TIL115, TIL118 OPTOCOUPERS

electrical characteristics at 25°C free-air temperature

PARAMETER	TEST CONDITIONS†	TIL112			TIL115			TIL118			UNIT
		MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
$V_{(BR)CBO}$	Collector-Base Breakdown Voltage $I_C = 10 \mu A$, $I_E = 0$	30			30						V
$V_{(BR)CEO}$	Collector-Emitter Breakdown Voltage $I_C = 1 mA$, $I_B = 0$	20			20			20			V
$V_{(BR)EBO}$	Emitter-Base Breakdown Voltage $I_E = 10 \mu A$, $I_C = 0$	4			4						V
$V_{(BR)ECO}$	Emitter-Collector Breakdown Voltage $I_E = 10 \mu A$, $I_F = 0$							4			V
$I_{C(on)}$	On-State Collector Current Phototransistor Operation $V_{CE} = 5 V$, $I_B = 0$	0.2	2		0.2	2		1	2		mA
	Photodiode Operation $V_{CB} = 5 V$, $I_F = 10 mA$, $I_E = 0$	2	10		2	10					μA
$I_{C(off)}$	Off-State Collector Current Phototransistor Operation $V_{CE} = 5 V$, $I_B = 0$		1	100		1	100		1	100	nA
	Photodiode Operation $V_{CB} = 5 V$, $I_F = 0$, $I_E = 0$		0.1	50		0.1	50				
h_{FE}	Transistor Static Forward Current Transfer Ratio $V_{CE} = 5 V$, $I_C = 10 mA$, $I_F = 0$	50	200		50	200					
V_F	Input Diode Static Forward Voltage $I_F = 10 mA$	1.2	1.5		1.2	1.5		1.2	1.5		V
$V_{CE(sat)}$	Collector-Emitter Saturation Voltage $I_C = 2 mA$, $I_F = 50 mA$, $I_B = 0$		0.5		0.5			0.5			V
r_{IO}	Input-to-Output Internal Resistance $V_{in-out} = \pm 1.5 kV$, See Note 6		10^{11}			10^{11}			10^{11}		Ω
C_{io}	Input-to-Output Capacitance $V_{in-out} = 0$, $f = 1 MHz$, See Note 6		1	2		1	2		1	2	pF

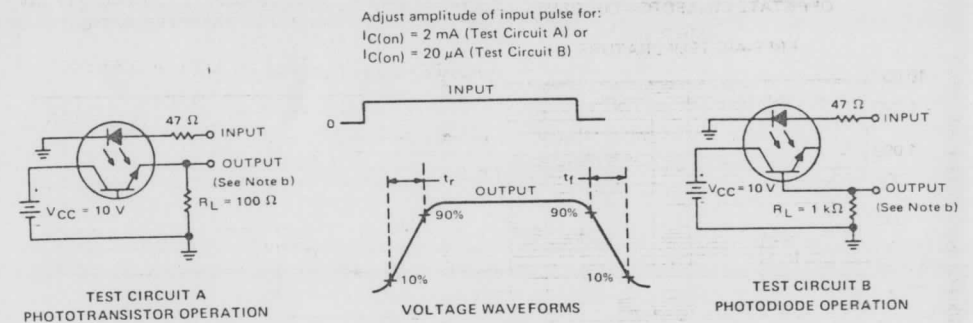
NOTE 6: These parameters are measured between both input-diode leads shorted together and all the phototransistor leads shorted together. †References to the base are not applicable for the TIL118.

switching characteristics at 25°C free-air temperature

PARAMETER	TEST CONDITIONS	TIL112			TIL115			TIL118			UNIT
		MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
t_r	Rise Time Phototransistor Operation $V_{CC} = 10 V$, $I_{C(on)} = 2 mA$, $R_L = 100 \Omega$, See Test Circuit A of Figure 1	2	15		2	15		2	15		μs
t_f	Fall Time Photodiode Operation $V_{CC} = 10 V$, $I_{C(on)} = 20 \mu A$, $R_L = 1 k\Omega$, See Test Circuit B of Figure 1	1			1			1			μs

TYPES TIL112, TIL115, TIL118 OPTOCOUPERS

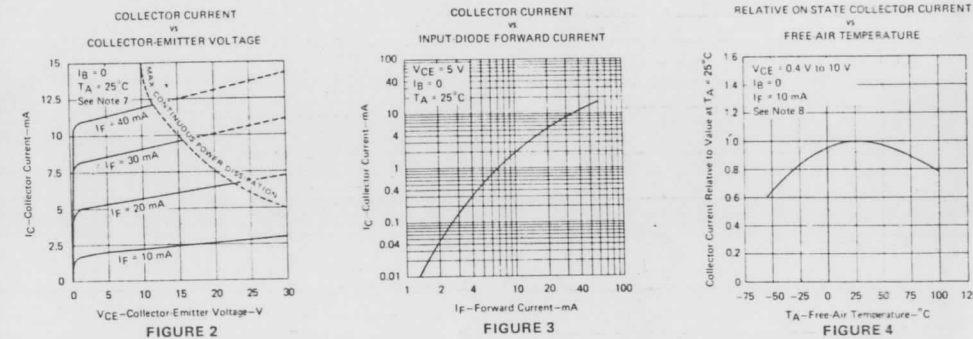
PARAMETER MEASUREMENT INFORMATION



NOTES: a. The input waveform is supplied by a generator with the following characteristics: $Z_{out} = 50 \Omega$, $t_r \leq 15 ns$, duty cycle $\approx 1\%$, $t_w = 100 \mu s$.
b. The output waveform is monitored on an oscilloscope with the following characteristics: $t_r \leq 12 ns$, $R_{in} > 1 M\Omega$, $C_{in} < 20 pF$.

FIGURE 1—SWITCHING TIMES

TYPICAL CHARACTERISTICS



NOTES: 7. Pulse operation of input diode is required for operation beyond limits shown by dotted lines.
8. These parameters were measured using pulse techniques $t_w = 1 ms$, duty cycle $\leq 2\%$.

TYPICAL CHARACTERISTICS

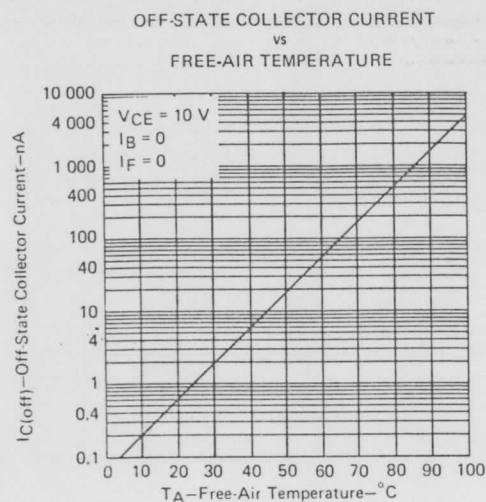


FIGURE 5

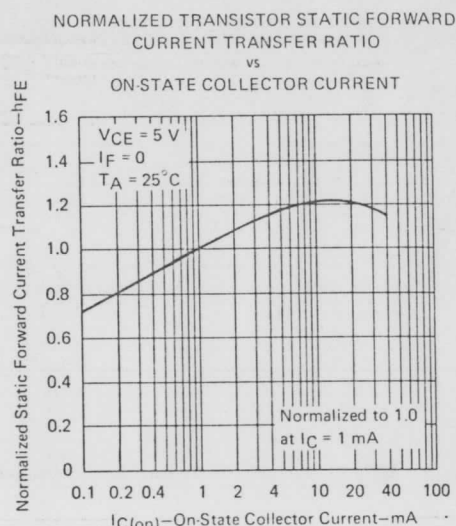


FIGURE 6

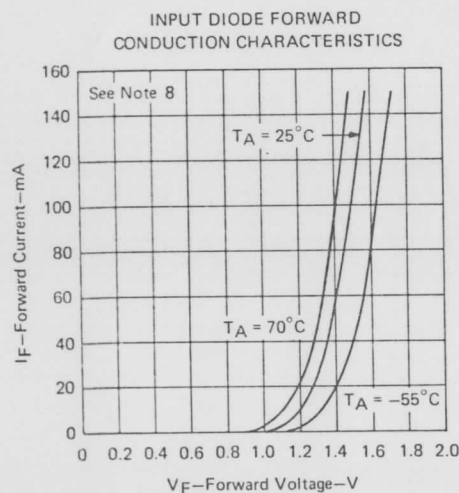


FIGURE 7

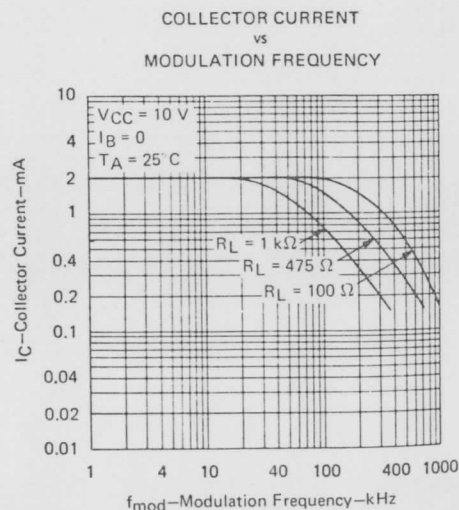


FIGURE 8

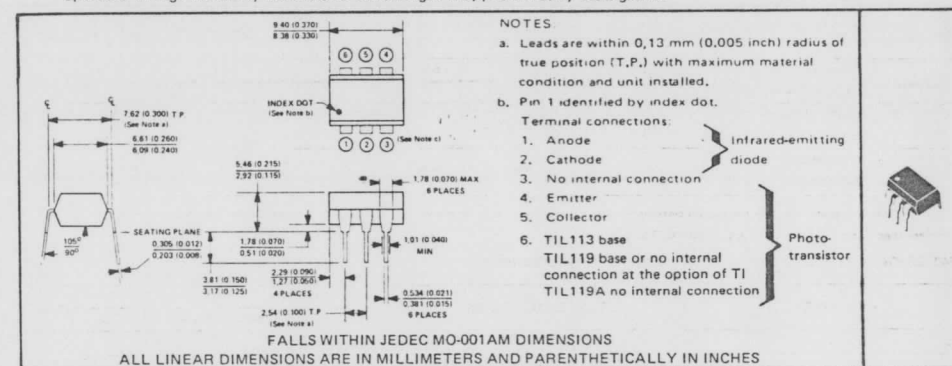
NOTE 8: These parameters were measured using pulse techniques. $t_w = 1$ ms, duty cycle $\leq 2\%$.

D1499, AUGUST 1981—REVISED FEBRUARY 1983

- Gallium Arsenide Diode Infrared Source Optically Coupled to a Silicon N-P-N Darlington-Connected Phototransistor
- High Direct-Current Transfer Ratio . . . 300% Minimum at 10 mA
- High-Voltage Electrical Isolation . . . 1500-Volt Rating
- Plastic Dual-In-Line Package
- Base Lead Provided on TIL113 for Conventional Transistor Biasing
- No Base Lead Connection on TIL119A for High-EMI Environments
- Typical Applications Include Remote Terminal Isolation, SCR and Triac Triggers, Mechanical Relays, and Pulse Transformers

mechanical data

The package consists of a gallium arsenide infrared-emitting diode and an n-p-n silicon darlington-connected phototransistor mounted on a 6-lead frame encapsulated within an electrically nonconductive plastic compound. The case will withstand soldering temperature with no deformation and device performance characteristics remain stable when operated in high-humidity conditions. Unit weight is approximately 0.52 grams.



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Input-to-Output Voltage	±1.5 kV
Collector-Base Voltage (TIL113)	30 V
Collector-Emitter Voltage (See Note 1)	30 V
Emitter-Collector Voltage	7 V
Emitter-Base Voltage (TIL113)	7 V
Input-Diode Reverse Voltage	3 V
Input-Diode Continuous Forward Current at (or below) 25°C Free-Air Temperature (See Note 2)	100 mA
Continuous Power Dissipation at (or below) 25°C Free-Air Temperature:	
Infrared-Emitting Diode (See Note 3)	150 mW
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 - Derate linearly to 100°C free air temperature at the rate of 2 mW/°C.
 - Derate linearly to 100°C free air temperature at the rate of 3.33 mW/°C.